

ULTRA LOW CAPACITANCE ESD PROTECTION DIODES ARRAY

Features

• Ultra low leakage: nA level

Operating voltage: 3.3V

• Low clamping voltage

• Complies with following standards:

- IEC 61000-4-2 (ESD) immunity test

Air discharge: ±25kV Contact discharge: ±15kV

- IEC61000-4-4 (EFT) 40A (5/50ns)

- IEC61000-4-5 (Lightning) 10A (8/20µs)

RoHS Compliant

Applications

- USB 3.0 /USB 3.1 Interfaces
- HDMI 1.4/HDMI2.0 Interfaces
- Video Graphics Cards
- Notebooks Desktops, and Servers
- Portable Instrumentation
- Industrial Controls

Mechanical Characteristics

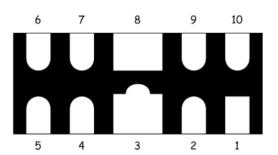
Package: DFN2510P10Lead Finish: Lead Free

UL Flammability Classification Rating 94V-0

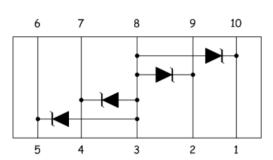
Quantity Per Reel:3,000pcs

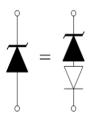
Reel Size:7 inch

Dimensions DFN2510P10



Pin Configuration





Configuration per Line

Absolute Maximum Ratings(Tamb=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Peak Pulse Power (8/20µs)	Ррр	150	W
ESD per IEC 61000-4-2 (Air)	- V _{ESD}	±25	Kv
ESD per IEC 61000-4-2 (Contact)	VESD	±15	NV
Operating Temperature Range	TJ	-55 to +125	${\mathbb C}$
Storage Temperature Range	Тѕтл	-55 to +150	$^{\circ}$



Electrical Characteristics(TA=25°C unless otherwise specified)

Part Number	Device Marking	V _{RWM} (V)	V _{BR} (V)	I _T (mA)	Vc @1A	(Max)	(@A)	I _R μΑ (Max)	C (pF) (Typ.)
ULC3314P	U314	3.3	4.0	1	7	20	10	1	0.3

♦ Note 1 : Any I/O to GND

Characteristic Curves

Fig1. 8/20µs Pulse Waveform

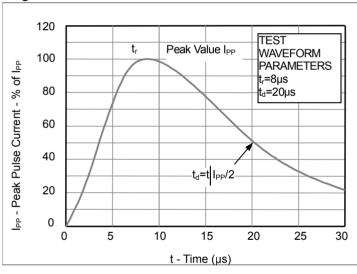


Fig2. ESD Pulse Waveform (according to IEC 61000-4-2)

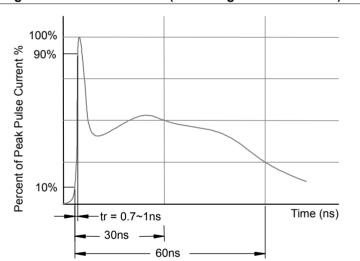
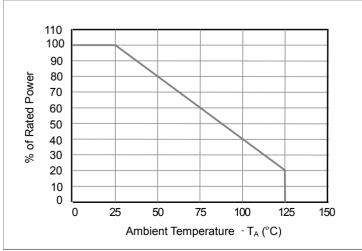


Fig3. Power Derating Curve

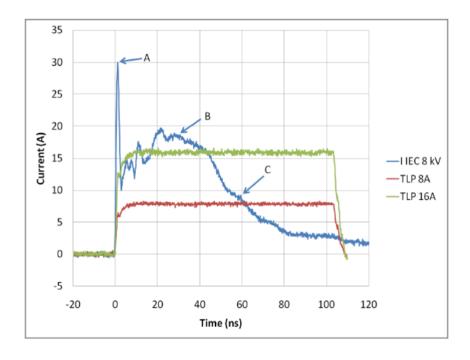


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Transmission Line Pulse (TLP)

Transmission Line Pulse (TLP) is a measurement technique used in the Electrostatic Discharge (ESD) arena to characterize performance attributes of devices under ESD stresses. TLP is able to obtain current versus voltage (I-V) curves in which each data point is obtained with a 100 ns long pulse, with currents up to 40 A TLP was first used in the ESD field to study human body model (HBM) in integrated circuits, but it is an equally valid tool in the field of system level ESD. The applicability of TLP to system level ESD is illustrated in Figure 1, which compares an 8 kV IEC 61000-4-2 current waveform with TLP current pulses of 8 and 16 The current levels and time duration for the pulses are similar and the initial rise time for the TLP pulse is comparable to the rise time of the IEC 61000-4-2's initial current spike. This application note will give a basic introduction to TLP measurements and explain the datasheet parameters extracted from TLP for Yeashin Technology's protection products.



Comparison of a Current Waveform of IEC 61000-4-2 with TLP Pulses at 8 and 16 A.

The IEC 61000-4-2 ESD waveforms is true to the Standard and is shown here as captured on an oscilloscope. The points A, B, and C show the points on the waveforms specified in IEC 61000-4-2.

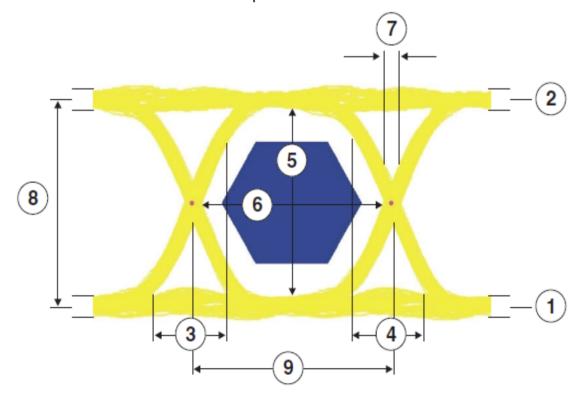
	4A (tp=100ns)	8A (tp=100ns)		
ULC3314P	6.5V(typ.)	14.5V(typ.)		

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Eye Diagram

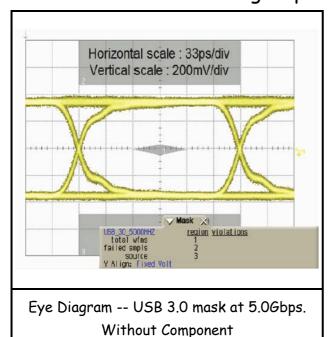
- Zero Level: measure of the mean value of the logical 0.
- 2 One Level: measure of the mean value of the logical 1.
- 3 Rise Time: measure of the transition time of the data from the 10% level to the 90% level on the upward slope.
- Fall Time: measure of the transition time of the data from the 90% level to the 10% level on the downward slope.
- 5 Eye Height: measure of the vertical opening.
 Determine eye closure due to noise.
- 6 Eye Width: measure of the horizontal opening.
 Determine influence of jitter on the eye opening.
- Deterministic Jitter: deviation of a transition from its ideal time caused by reflections relative to other transitions.
- 8 Eye Amplitude: difference between the logic 0 level and the logic 1 level histogram mean value.
- 9 Bit Rate: inverse of the bit period.



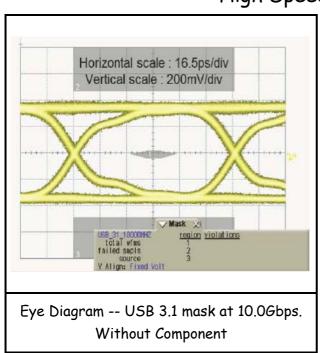


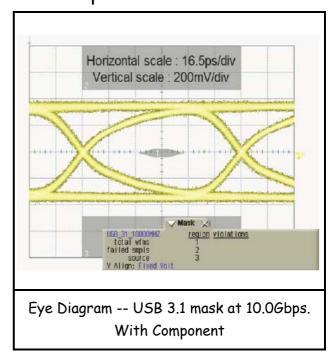
Eye Diagram at 5Gbps and 10Gbps

High Speed Test: 5Gbps



High Speed Test: 10Gbps

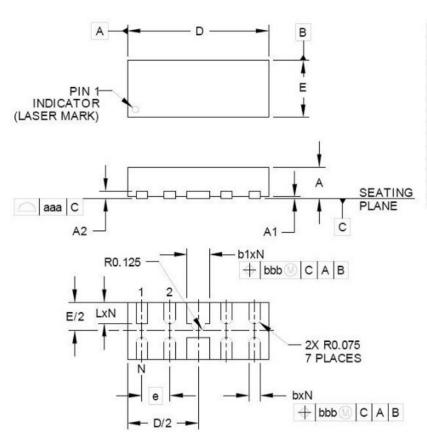




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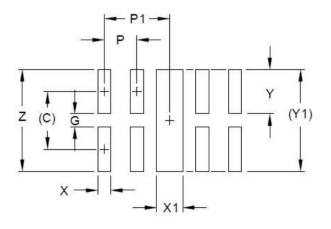


DFN2510P10 PACKAGE OUTLINE & DIMENSIONS



DIMENSIONS							
DIM	11	VCHE	S	MILLIMETERS			
	MIN	NOM	MAX	MIN	MOM	MAX	
Α	.020	.023	.026	0.50	0.58	0.65	
A1	0.00	.001	.002	0.00	0.03	0.05	
A2	(.005)			(0.13)			
b	.006	.008	.010	0.15	0.20	0.25	
b1	.014	.016	.018	0.35	0.40	0.45	
D	.094	.098	.102	2.40	2.50	2.60	
Е	.035	.039	.043	0.90	1.00	1.10	
е	.020 BSC			0.50 BSC			
L	.012	.015	.017	0.30	0.38	0.425	
N	10			10			
aaa	.003			0.08			
bbb	.004			0.10			

* SOLDERING FOOTPRINT



DIMENSIONS					
DIM	INCHES	MILLIMETERS			
С	(.034)	(0.875)			
G	.008	0.20			
Р	.020	0.50			
P1	.039	1.00			
X	.008	0.20			
X1	.016	0.40			
Υ	.027	0.675			
Y1	(.061)	(1.55)			
Z	.061	1.55			

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